

DS90C031QML LVDS Quad CMOS Differential Line Driver

Check for Samples: DS90C031QML

FEATURES

- Radiation guaranteed 100 krad(Si)
- High impedance LVDS outputs with power-off
- ±350 mV differential signaling
- Low power dissipation
- Low differential skew
- Low propagation delay
- Pin compatible with DS26C31
- Compatible with IEEE 1596.3 SCI LVDS standard
- Compatible with proposed TIA LVDS standard
- Fail safe logic for floating inputs

DESCRIPTION

The DS90C031 is a quad CMOS differential line driver designed for applications requiring ultra low power dissipation and high data rates.

The DS90C031 accepts TTL/CMOS input levels and translates them to low voltage (350 mV) differential output signals. In addition the driver supports a TRI-STATE function that may be used to disable the output stage, thus dropping the device to a low idle power state of 11 mW typical.

In addition, the DS90C031 provides power-off high impedance LVDS outputs. This feature assures minimal loading effect on the LVDS bus lines when V_{CC} is not present. The DS90C031 and companion line receiver (DS90C032) provide a new alternative to high power psuedo-ECL devices for high speed pointto-point interface applications.

Connection Diagram

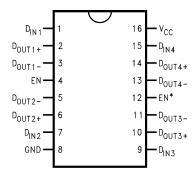


Figure 1. Dual-In-Line See Package Number NAD0016A & NAC0016A

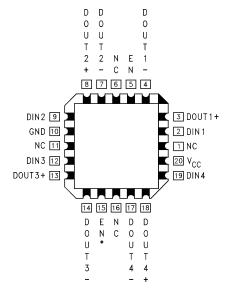
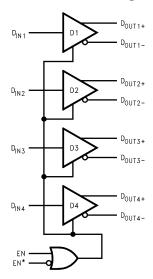


Figure 2. LCCC Package See Pacakage Number NAJ0020A

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Functional Block Diagram



Truth Table

Ena	bles	Input	Out	puts
EN	EN*	D _I	D _{O+}	D _O -
L	Н	X	Z	Z
All other cor	nbinations of	L	L	Н
ENABL	E inputs	Н	Н	L

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings(1)

Absolute Maximum Natings	
Supply Voltage (V _{CC})	-0.3V to +6V
Input Voltage (D _I)	-0.3V to (V _{CC} + 0.3V)
Enable Input Voltage (EN, EN*)	-0.3V to (V _{CC} + 0.3V)
Output Voltage (D _{O+} , D _{O-})	-0.3V to + 5.8V
Storage Temperature Range	-65°C ≤ T _A ≤ +150°C
Lead Temperature Range, Soldering (4 seconds)	+260°C
Maximum Package Power Dissipation at +25°C (2)	·
20 Pin LCCC Package	1900 mW
16 Pin CLGA (NAD)	1450 mW
16 Pin CLGA (NAC)	1450 mW
Thermal Resistance	
θ_{JA}	
20 Pin LCCC Package	78°C/W
16 Pin CLGA (NAD)	145°C/W
16 Pin CLGA (NAC)	145°C/W
θ_{JC}	
20 Pin LCCC Package	18°C/W
16 Pin CLGA (NAD)	14°C/W
16 Pin CLGA (NAC)	14°C/W
ESD Rating (3)	3.5KV

Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Derate LCCC at 12.8mW/°C above +25°C. Derate CLGA at 6.9mW/°C above +25°C. Human body model, 1.5 k Ω in series with 100 pF.

Recommended Operating Conditions

	Min	Тур	Max	Unit
Supply Voltage (V _{CC})	+4.5	+5.0	+5.5	V
Operating Free Air Temperature (T _A)	- 55	+25	+125	°C

Product Folder Links: DS90C031QML



Quality Conformance Inspection

Table 1. Mil-Std-883, Method 5005 - Group A

Subgroup	Description	Temp (°C)
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55
12	Settling time at	+25
13	Settling time at	+125
14	Settling time at	-55

DC Parameters (1)

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub- groups
V _{OD1}	Differential Ouput Voltage	$R_L = 100\Omega$		250	450	mV	1, 2, 3
DV _{OD1}	Change in Magnitude of Vod1 for complementary output States	$R_L = 100\Omega$			35	mV	1, 2, 3
V _{OS}	Offset Voltage	$R_L = 100\Omega$		1.12 5	1.37 5	V	1, 2, 3
DV _{OS}	Change in Magnitude of Vos for Complementary Output States	$R_L = 100\Omega$			25	mV	1, 2, 3
V _{OH}	Output Voltage High	$R_L = 100\Omega$			1.6	V	1, 2, 3
V _{OL}	Output Voltage Low	$R_L = 100\Omega$		0.9		V	1, 2, 3
V _{IH}	Input Voltage High		(2)	2.0	V _{CC}	V	1, 2, 3
V _{IL}	Input Voltage Low		(2)	Gnd	0.8	V	1, 2, 3
I _I	Input Current	$V_{I} = V_{CC}$, Gnd, 2.5, or 0.4V			±10	μΑ	1, 2, 3
V _{CI}	Input Clamp Voltage	I _{CI} = -18mA			-1.5	V	1, 2, 3
Ios	Output Short Circuit Current	V _O = 0V			-5.0	mA	1, 2, 3
I _{Off}	Power-off Leakage	V _O = 0V or 2.4V, V _{CC} -= 0V or Open			±10	μΑ	1, 2, 3
I _{OZ}	Output TRI-STATE Current	$EN = 0.8V$ and $EN^* = 2.0V$ $V_O = 0V$ or V_{CC}			±10	μΑ	1, 2, 3
I _{CC}	Drivers Enabled Supply Current	D _I = Hi or Low			25	mA	1, 2, 3
I _{CCZ}	Drivers Disabled Supply Current	D_I = Hi or Low, En = Gnd, En* = V_{CC}			10	mA	1, 2, 3

⁽¹⁾ Pre and Post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the "Post Radiation Limits" table. Radiation end point limits for the noted parameters are guaranteed only for the conditions, as specified.

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⁽²⁾ Tested during V_{OH} / V_{OL} tests.



AC Parameters

The following conditions apply, unless otherwise specified.

AC: $V_{CC} = 4.5 \text{V} / 5.0 \text{V} / 5.5 \text{V}$, $R_L = 100 \Omega$ (between outputs), $C_L = 20 \text{pF}$ (each output to Gnd)

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub- groups
t _{PHLD}	Differential Propagation Delay High to Low			0.5	5.0	ns	9, 10, 11
t _{PLHD}	Differential Propagation Delay Low to High			0.5	5.0	ns	9, 10, 11
t _{SkD}	Differential Skew tPHLD-tPLHD				3.0	ns	9, 10, 11
t _{Sk1}	Channel to Channel Skew		(1)		3.0	ns	9, 10, 11
t _{Sk2}	Chip to Chip Skew		(2)		4.5	ns	9, 10, 11
t _{PHZ}	Disable Time High to Z		(3)		20	ns	9, 10, 11
t _{PLZ}	Disable Time Low To Z		(3)		20	ns	9, 10, 11
t _{PZH}	Enable Time Z to High		(3)		20	ns	9, 10, 11
t _{PZL}	Enable Time Z to Low		(3)		20	ns	9, 10, 11

⁽¹⁾ Channel-to-Channel Skew is defined as the difference between the propagation delay of the channel and the other channels in the same chip with an event on the inputs.

AC/DC Parameters - Post Radiation Limits (1)

Symbol	Parameter	Conditions	Notes	Min	Max	Units	Sub- groups
I _{CC}	Drivers Enabled Supply Current	D_{l} - Hi or Low, En = Gnd, En* = V_{CC}			30	mA	1
I _{CCZ}	Drivers Disabled Supply Current	D_{I} - Hi or Low, En = Gnd, En* = V_{CC}			30	mA	1

(1) Pre and Post irradiation limits are identical to those listed under AC and DC electrical characteristics except as listed in the "Post Radiation Limits" table. Radiation end point limits for the noted parameters are guaranteed only for the conditions, as specified.

Product Folder Links: DS90C031QML

⁽²⁾ Chip to Chip Skew is defined as the difference between the minimum and maximum specified differential propagation delays.

⁽³⁾ Parameter guaranteed, not tested 100%



Parameter Measurement Information

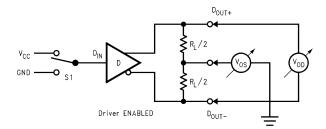


Figure 3. Driver V_{OD} and V_{OS} Test Circuit

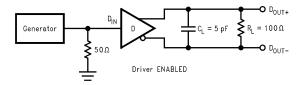


Figure 4. Driver Propagation Delay and Transition Time Test Circuit

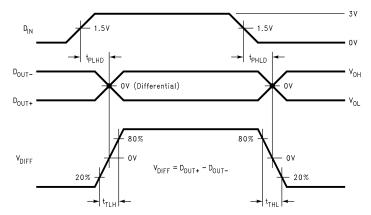


Figure 5. Driver Propagation Delay and Transition Time Waveforms

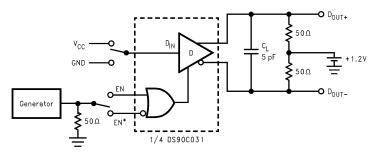


Figure 6. Driver TRI-STATE Delay Test Circuit

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Parameter Measurement Information (continued)

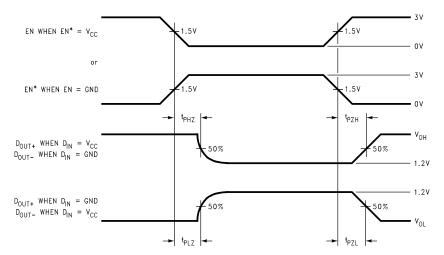


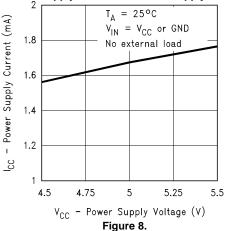
Figure 7. Driver TRI-STATE Delay Waveform



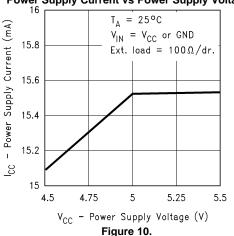
Typical Performance Characteristics

Product Folder Links: DS90C031QML

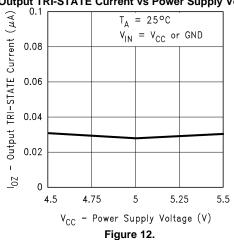
Power Supply Current vs Power Supply Voltage



Power Supply Current vs Power Supply Voltage



Output TRI-STATE Current vs Power Supply Voltage



Power Supply Current vs Temperature

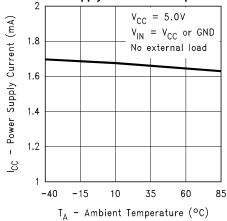


Figure 9.

Power Supply Current vs Temperature

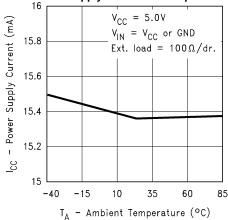


Figure 11.

Output Short Circuit Current vs Power Supply Voltage

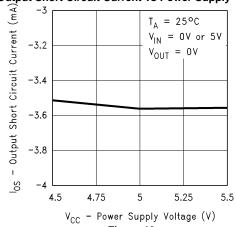
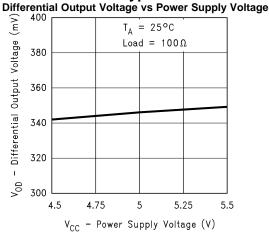


Figure 13.



Typical Performance Characteristics (continued)



Output Voltage High vs Power Supply Voltage

Figure 14.

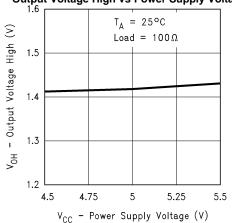
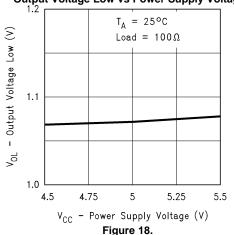


Figure 16. Output Voltage Low vs Power Supply Voltage



Differential Output Voltage vs Ambient Temperature

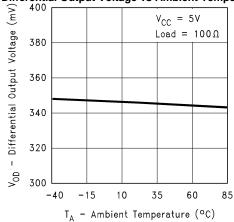


Figure 15.

Output Voltage High vs Ambient Temperature

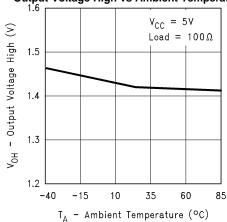


Figure 17.

Output Voltage Low vs Ambient Temperature

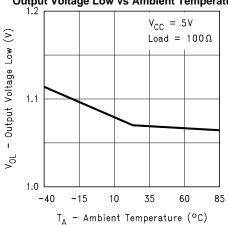
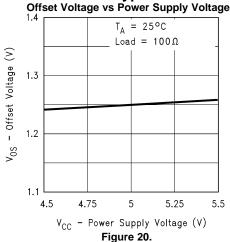
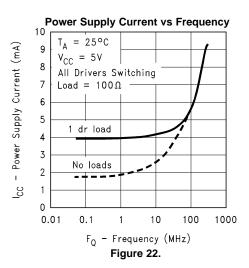


Figure 19.



Typical Performance Characteristics (continued)





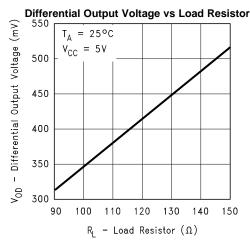
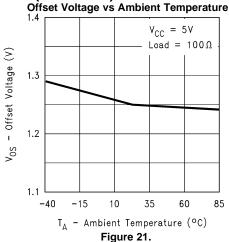
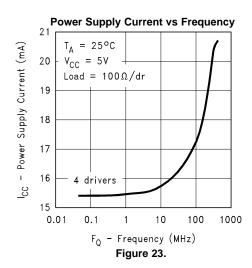
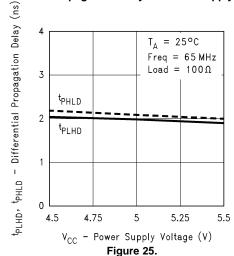


Figure 24.





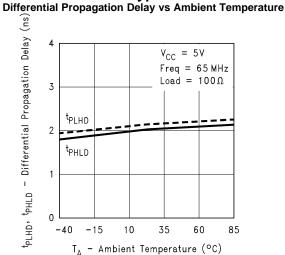
Differential Propagation Delay vs Power Supply Voltage



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Typical Performance Characteristics (continued)



Differential Skew vs Power Supply Voltage

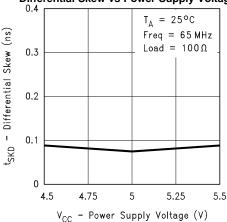
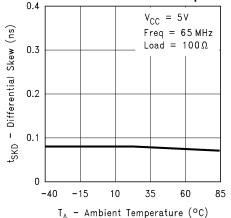


Figure 27.

Figure 26. **Differential Skew vs Ambient Temperature**



Differential Transition Time vs Power Supply Voltage

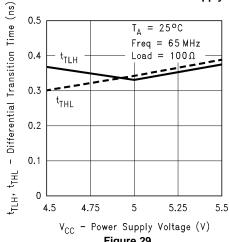


Figure 29.

Figure 28.

Differential Transition Time vs Ambient Temperature

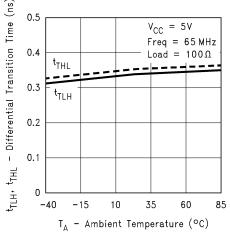


Figure 30.



TYPICAL APPLICATION

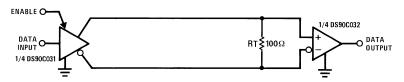


Figure 31. Point-to-Point Application

APPLICATIONS INFORMATION

LVDS drivers and receivers are intended to be primarily used in an uncomplicated point-to-point configuration as is shown in Figure 31. This configuration provides a clean signaling environment for the quick edge rates of the drivers. The receiver is connected to the driver through a balanced media which may be a standard twisted pair cable, a parallel pair cable, or simply PCB traces. Typically, the characteristic impedance of the media is in the range of 100Ω . A termination resistor of 100Ω should be selected to match the media, and is located as close to the receiver input pins as possible. The termination resistor converts the current sourced by the driver into a voltage that is detected by the receiver. Other configurations are possible such as a multi-receiver configuration, but the effects of a mid-stream connector(s), cable stub(s), and other impedance discontinuities as well as ground shifting, noise margin limits, and total termination loading must be taken into account.

The DS90C031differential line driver is a balanced current source design. A current mode driver, generally speaking has a high output impedance and supplies a constant current for a range of loads (a voltage mode driver on the other hand supplies a constant voltage for a range of loads). Current is switched through the load in one direction to produce a logic state and in the other direction to produce the other logic state. The typical output current is mere 3.4 mA, a minimum of 2.5 mA, and a maximum of 4.5 mA. The current mode **requires** (as discussed above) that a resistive termination be employed to terminate the signal and to complete the loop as shown in Figure 31. AC or unterminated configurations are not allowed. The 3.4 mA loop current will develop a differential voltage of 340 mV across the 100Ω termination resistor which the receiver detects with a 240 mV minimum differential noise margin neglecting resistive line losses (driven signal minus receiver threshold (340 mV - 100 mV = 240 mV)). The signal is centered around +1.2V (Driver Offset, V_{OS}) with respect to ground as shown in Figure 32. Note that the steady-state voltage (V_{SS}) peak-to-peak swing is twice the differential voltage (V_{OD}) and is typically 680 mV.

The current mode driver provides substantial benefits over voltage mode drivers, such as an RS-422 driver. Its quiescent current remains relatively flat versus switching frequency. Whereas the RS-422 voltage mode driver increases exponentially in most case between 20 MHz–50 MHz. This is due to the overlap current that flows between the rails of the device when the internal gates switch. Whereas the current mode driver switches a fixed current between its output without any substantial overlap current. This is similar to some ECL and PECL devices, but without the heavy static I_{CC} requirements of the ECL/PECL designs. LVDS requires > 80% less current than similar PECL devices. AC specifications for the driver are a tenfold improvement over other existing RS-422 drivers.

The TRI-STATE function allows the driver outputs to be disabled, thus obtaining an even lower power state when the transmission of data is not required. The LVDS outputs are high impedance under power-off condition. This allows for multiple or redundant drivers to be used in certain applications.

The footprint of the DS90C031 is the same as the industry standard 26LS31 Quad Differential (RS-422) Driver.

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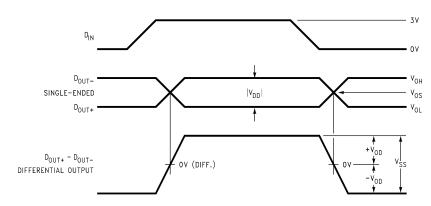


Figure 32. Driver Output Levels

Pin Descriptions

Pin No. (SOIC)	Name	Description				
1, 7, 9, 15	D _I	Driver input pin, TTL/CMOS compatible				
2, 6, 10, 14	D _{O+}	Non-inverting driver output pin, LVDS levels				
3, 5, 11, 13	D _O -	Inverting driver output pin, LVDS levels				
4	EN	Active high enable pin, OR-ed with EN*				
12	EN*	Active low enable pin, OR-ed with EN				
16	V _{CC}	Power supply pin, +5V ± 10%				
8	Gnd	Ground pin				

Radiation Environments

Careful consideration should be given to environmental conditions when using a product in a radiation environment.

Total Ionizing Dose

Radiation hardness assured (RHA) products are those part numbers with a total ionizing dose (TID) level specified in the Ordering Information table on the front page. Testing and qualification of these products is done on a wafer level according to MIL-STD-883G, Test Method 1019.7, Condition A and the "Extended room temperature anneal test" described in section 3.11 for application environment dose rates less than 0.16 rad(Si)/s. Wafer level TID data is available with lot shipments.

Single Event Latch-Up

One time single event latch-up (SEL) testing was preformed showing SEL immunity to 103 MeV-cm²/mg. A test report is available upon request.

Single Event Upset

Single event upset (SEU) data are available upon request.



REVISION HISTORY

Released	Revision	Section	Changes
03/01/06	New	New Release, Corporate format	1 MDS data sheet converted into Corp. data sheet format. MNDS90C031-X-RH Rev 2A1 will be archived.
10/12/2010	А	Features, Ordering Table, Absolute Maximum Ratings, Applications Information	Added reference to Radiation and Fail safe. Removed reference to EOL NSID, Output Voltage changed limit from $-0.3V$ to $(V_{\rm CC}+0.3V)$ to $-0.3V$ to $+5.8V$, Added paragraph to Applications Information section and New Radiation Environment section. Revision A will be Archived.
03/04/2013	В	All	Changed layout of National Data Sheet to TI format.

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Product Folder Links: DS90C031QML

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PACKAGING INFORMATION

Orderable part number	Status	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
5962-9583301Q2A	Active	Production	LCCC (NAJ) 20	50 TUBE	Yes	Call TI	Level-1-NA-UNLIM	-55 to 125	DS90C031E -QML Q 5962-95833 01Q2A ACO 01Q2A >T
5962-9583301VFA	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031W- QMLV Q 5962-95833 01VFA ACO 01VFA >T
5962R9583301VFA	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WR QMLV Q 5962R95833 01VFA ACO 01VFA >T
5962R9583301VZA	Active	Production	CFP (NAC) 16	88 JEDEC TRAY (5+1)	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WGR QMLV Q 5962R95833 01VZA ACO 01VZA >T
DS90C031 MDR	Active	Production	DIESALE (Y) 0	28 OTHER	Yes	Call TI	Level-1-NA-UNLIM	-55 to 125	
DS90C031-MDR.A	Active	Production	DIESALE (Y) 0	28 OTHER	Yes	Call TI	Level-1-NA-UNLIM	-55 to 125	
DS90C031E-QML	Active	Production	LCCC (NAJ) 20	50 TUBE	Yes	Call TI	Level-1-NA-UNLIM	-55 to 125	DS90C031E -QML Q 5962-95833 01Q2A ACO 01Q2A >T
DS90C031E-QML.A	Active	Production	LCCC (NAJ) 20	50 TUBE	Yes	Call TI	Level-1-NA-UNLIM	-55 to 125	DS90C031E -QML Q 5962-95833 01Q2A ACO 01Q2A >T





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Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
DS90C031W-QMLV	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031W- QMLV Q 5962-95833 01VFA ACO 01VFA >T
DS90C031W-QMLV.A	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031W- QMLV Q 5962-95833 01VFA ACO 01VFA >T
DS90C031WGRQMLV	Active	Production	CFP (NAC) 16	88 JEDEC TRAY (5+1)	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WGR QMLV Q 5962R95833 01VZA ACO 01VZA >T
DS90C031WGRQMLV.A	Active	Production	CFP (NAC) 16	88 JEDEC TRAY (5+1)	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WGR QMLV Q 5962R95833 01VZA ACO 01VZA >T
DS90C031WRQMLV	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WR QMLV Q 5962R95833 01VFA ACO 01VFA >T
DS90C031WRQMLV.A	Active	Production	CFP (NAD) 16	19 TUBE	No	SNPB	Level-1-NA-UNLIM	-55 to 125	DS90C031WR QMLV Q 5962R95833 01VFA ACO 01VFA >T

⁽¹⁾ Status: For more details on status, see our product life cycle.

⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

PACKAGE OPTION ADDENDUM

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(4) Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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OTHER QUALIFIED VERSIONS OF DS90C031QML, DS90C031QML-SP:

Military: DS90C031QML

Space : DS90C031QML-SP

NOTE: Qualified Version Definitions:

• Military - QML certified for Military and Defense Applications

• Space - Radiation tolerant, ceramic packaging and qualified for use in Space-based application

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TUBE

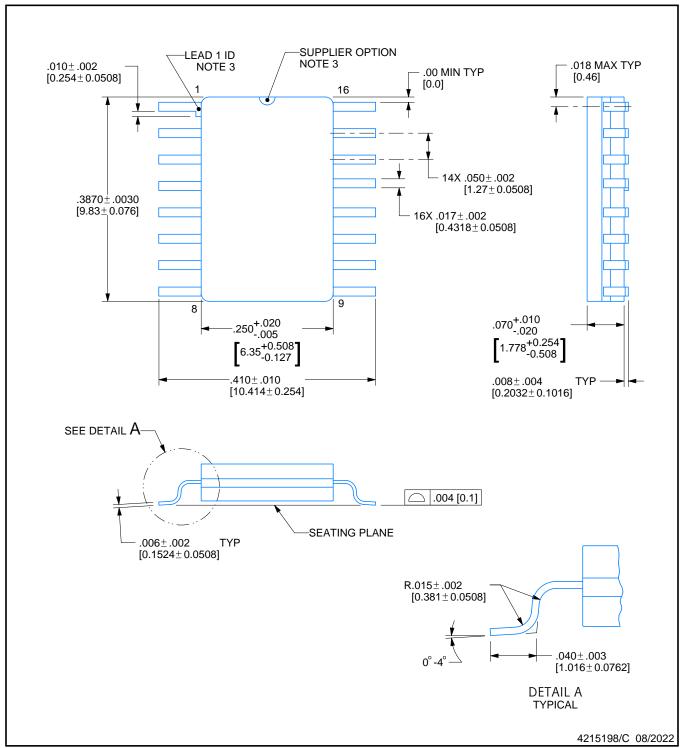


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9583301Q2A	NAJ	LCCC	20	50	470	11	3810	0
5962-9583301VFA	NAD	CFP	16	19	502	23	9398	9.78
5962R9583301VFA	NAD	CFP	16	19	502	23	9398	9.78
DS90C031E-QML	NAJ	LCCC	20	50	470	11	3810	0
DS90C031E-QML.A	NAJ	LCCC	20	50	470	11	3810	0
DS90C031W-QMLV	NAD	CFP	16	19	502	23	9398	9.78
DS90C031W-QMLV.A	NAD	CFP	16	19	502	23	9398	9.78
DS90C031WRQMLV	NAD	CFP	16	19	502	23	9398	9.78
DS90C031WRQMLV.A	NAD	CFP	16	19	502	23	9398	9.78



CERAMIC FLATPACK

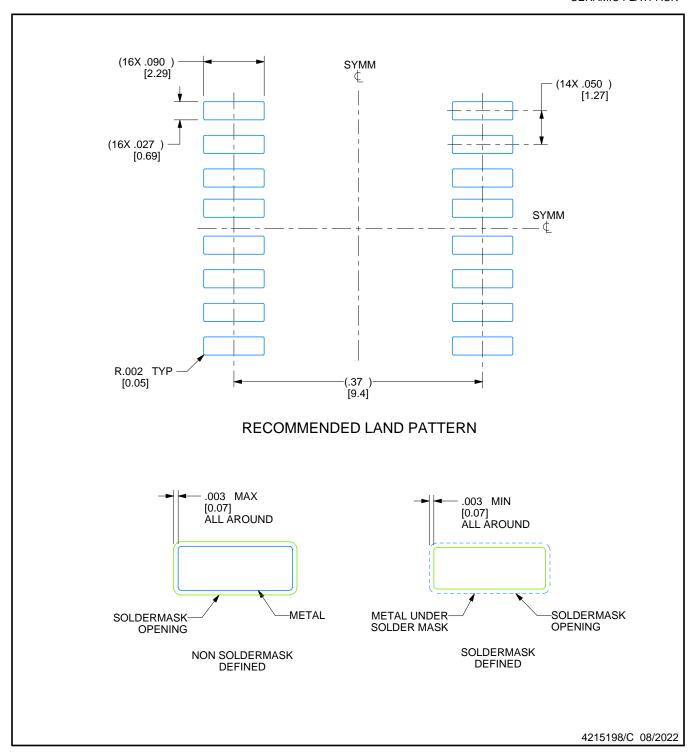


NOTES:

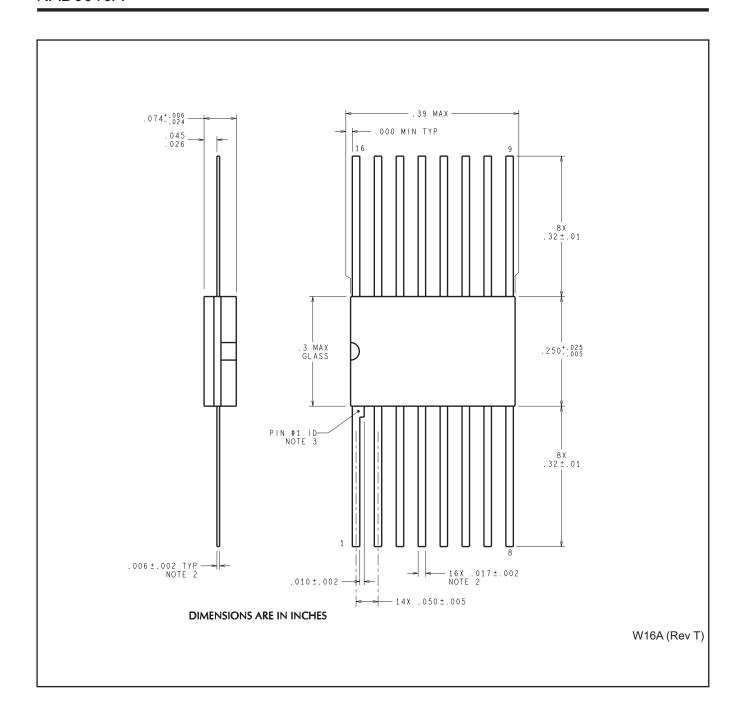
- 1. Controlling dimension is Inch. Values in [] are milimeters. Dimensions in () for reference only.
 2. For solder thickness and composition, see the "Lead Finish Composition/Thickness" link in the packaging section of the Texas Instruments website
- 3. Lead 1 identification shall be:
 - a) A notch or other mark within this area
 - b) A tab on lead 1, either side
- 4. No JEDEC registration as of December 2021



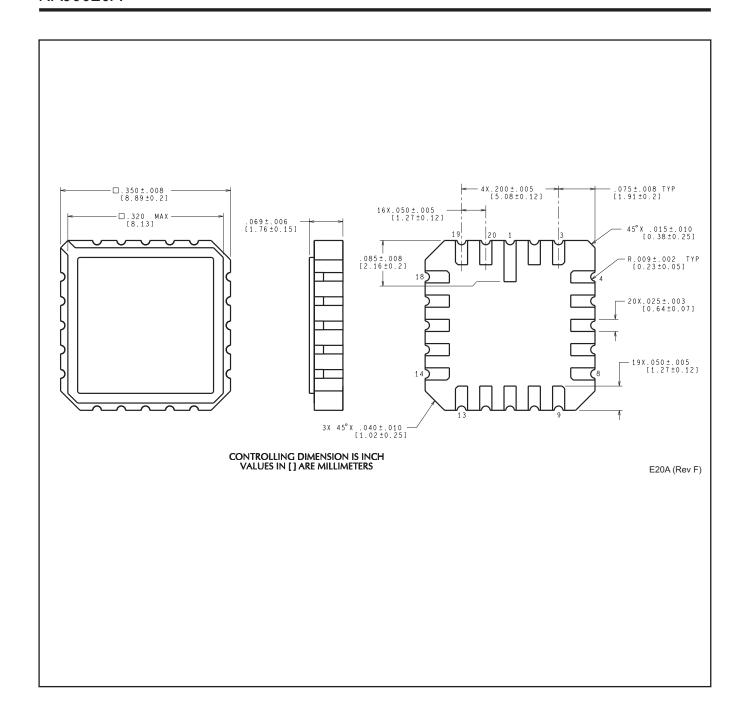
CERAMIC FLATPACK



REVISIONS							
REV	DESCRIPTION	vic	2.3.10	E.C.N.	DATE	BY/AP	P'D
A B C	RELEASE TO DOCUMENT CONTROL NO CHANGE TO DRAWING; REVISION FOR YODA RELEASE; .387± .003 WAS .39000± .00012;			2197879 2198832 2200917	12/30/2021 02/15/2022 08/08/2022	TINA TRAN / A K. SINCE D. CHIN / K. S	ANIS FAUZI RBOX
		SCALE	SIZE A		421519	98	REV PAGE 4 OF 4







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